

FORM PTO-1449 (REV. 7-80)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. : OBIKANE ET AL 1		SERIAL NO. 10/673,900	
LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT : HIROAKI OBIKANE ET AL			
FILING DATE: Sept. 29, 2003				GROUP: 2839			

U.S. PATENT DOCUMENTS							
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						

FOREIGN PATENT DOCUMENTS								
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION		
						YES	NO	
MCE	AH	09-364881	12/1997	Japan				
↓	AI	2001-126789	05/2001	Japan				
↓	AJ	2002-033145	01/2002	Japan				
	AK							
	AL							
	AM							
	AN							
	AO							

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)			
EXAMINER	AP		
	AQ		

EXAMINER <i>Michael C. Zanolis</i>	DATE CONSIDERED <i>2/21/05</i>
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO-1449 (Modified) (REV. 7-80)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO.: OBIKANE ET AL.-1		SERIAL NO.: 10/673,900	
LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT: HIROAKI OBIKANE ET AL - 1			
				FILING DATE: SEPT. 29, 2003		GROUP: 2833 2839	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
MCZ	AA	5,928,031	7/1999	Chishima	439	571	
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
MCZ	AL	EP 0 440 016 A1	08/1991	DE			
	AM	EP 0 538 029 A2	4/1993	GB			
	AN	EP 1 148 597 A2	10/2001	DE			
	AO	EP 0 795 939 A2	9/1997	DE			
	AP	EP 0 685 907 A2	12/1995	GB			
	AQ						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)							
	AR						
	AS						
	AT						
EXAMINER <i>Richard C. Zano</i>				DATE CONSIDERED 10/22/04			

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 608; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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FORM PTO-1449 (Modified)
(REV. 7-80)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO.:

OBIKANE ET AL.-1

SERIAL NO.:

LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

APPLICANT:

HIROAKI OBIKANE ET AL.

FILING DATE:

GROUP: 2839

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
MCE	AL	JP-U-H05-23429	03/1993	JAPAN			X	
	AM							
	AN							
	AO							
	AP							

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	AR			
	AS			
	AT			

EXAMINER

Michael C. Zanolis

DATE CONSIDERED

10/21/04

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 809; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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